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UYGR- * S03 H3116 D/32 *EP-32-774 Reflection meter with optical fibre illuminating at 45 degrees has optical fibre receiving normal reflection with frames of measurement and illumination of order of depth of light penetration

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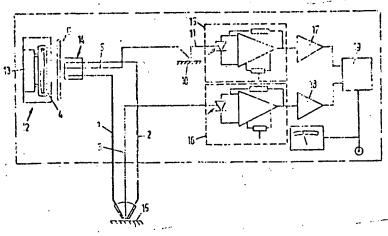
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An optical reflection meter includes a light source (14), a probe head, a light detector (15), at least one optic illumination fibre (1,2) between the source and head, and one optic measuring fibre (3) between the head and detector. The geometry maintained relative to the surface to be measured for illumination of the surface and for reception of the reflected light are 45 degrees and 200 degrees respectively. The surface area to be measured, or frame of measurement, determined by the fibre (3), is of the order of the depth of light penetration into the material to be measured, or less, and the portion of the surface to be measured illuminated by fibres (1,2), or frame of illumination, is of at least the same size of the frame of measurement or larger.

Such a meter permits accurate and reproducible measurements of a translucent material, from very small surfaces, which may or may not be confined in a small space, to large surfaces, and, within a wide range, independently of the curvature of the surface. (20pp Dwg.No.1)

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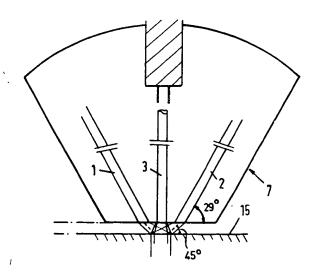
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- (54) Optical reflection meter.
- An optical reflection meter for making accurate and reproducible measurements on a translucent material. The meter is characterized in that the probe head comprises one optical measuring fibre; the geometry maintained relative to the surface being measured for illumination of said surface and for reception of the light reflected is 45° and 0°, respectively; the surface area to be measured, or frame of measurement, determined by said optical measuring fibre, being of the order of the depth of light penetration into the substance being measured, or less, and the portion of the surface to be measured illuminated by the optical illumination fibre, or frame of illumination, being of at least substantially the same size as the frame of measurement or larger.



"Optical reflection meter"

This invention relates to an optical reflection meter, suitable for reflectivity measurement on a shaped or shapeless translucent material, comprising a light source, a probe head, a light detection means, at least one optic illumination fibre between the light source and the probe head for illuminating the surface being measured, and at least one optic measuring fibre between the probe head and the light detection means for receiving the reflected light and conducting this to the light detection means.

In an article by L.A. Lott and D.L. Cahs in Applied Optics 4 (1973) 837-840, there is described an apparatus for spectral reflectivity measurements on surfaces having specular and diffuse reflectivity characteristics, the prior reflectivity meter being suitable for use on large objects, objects having nonplanar surfaces, or surfaces of toxic or radio active materials which must be stored in a protective case. The reflection meter comprises a plurality of optic fibres combined into a main bundle, one end of which is connected to a probe head, which is placed on the surface to be measured, and in the direction of the other end thereof is bifurcated into two branches each comprising a plurality of fibres.

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a mirror to a monochromator section of a spectrophotometer, from which it receives the light with which the surface to be measured is illuminated, and the other branch is optically connected via a mirror to a measuring section, and thus conducts the reflected light collected in the probe head to the measuring section. The optic fibres of each of the branches are randomly distributed in the main bundle, so that half of the reflected light is conducted to the measuring section.

The main bundle with the optic fibres constituting it is fixed in the probe head, the latter being made of Teflon (a registered trademark for polytetrafluoroethylene) in such a manner that the geometry for the illumination of the surface to be measured and collection of the returning, reflected light is 0° and 0°, respectively (both parallel to the normal). The distance of the plane of the fibre ends in the probe head from the surface to be measured is adjustable.

F.W. Billmeijer and D.C. Rich in an article in Plastics Engineering, of December 1978, pages 35-39, give a survey of colour measuring instruments available to the art. In a separate paragraph, the authors enter into the optical measurement of translucent materials, with regard to which they state that an accurate measurement of such a material is extremely difficult and in fact a problem still unsolved.

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It is an object of the present invention to provide an optical reflectivity meter which permits accurate and reproducible measurements of a translucent material, from very small surfaces, which may or may not be confined in a small space, to large surfaces, and, within a wide range, independently of the curvature of the surface.

According to the invention, there is provided an optical reflection meter of the kind specified above, which is characterized in that the probe head comprises one optical measuring fibre; the geometry maintained relatively to the surface to be measured for illumination of the surface to be measured and for collection of the reflected light being 45° and 0°, respectively; the srface area—to be measured or frame of measurement, determined by the optic measuring fibre, being of the order of the depth—of light penetration into the substance being measured, or less, and the portion of the surface to be measured illuminated by the optic illuminating fibre, or frame of illumination, being of at least substantially the same size as the frame of measurement or larger.

By the term "reflection" or term derived from it or combinations thereof is understood the phenomenon as defined by the Commission Internationale de l'Eclairage (C.I.E.), published in Publication C.I.E. No. 38 (TC-2.3) 1977, pages 77-78, namely, that reflection is the return of radiation through a medium without a change in wave-

length, it being noted that the reflected radiation may be regular, diffuse or mixed, while, according to another distinction, when the radiation flux is caused to fall on the surface of a medium, the reflection which occurs may be partly reflected by the surface (surface reflection), and for another part may be reflected from the interior of the medium (volume reflection).

Regular or specular reflection means reflection without diffusion, in accordance with the laws of optical reflection as in a mirror.

When light is caused to fall on the surface of translucent material the following components may contribute to the reflected light:

- 1. Surface reflection, which may be composed of:
 - a. specular reflection and

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- b. diffuse reflection, caused by surface roughness;
- 2. Volume reflection, which may be composed of:
 - a. light which has penetrated into the translucent material and again reaches the surface by (back)scattering, this process being defined by the linear scattering coefficient; and
 - b. if the layer of material is sufficiently thin, light from specular and/or diffuse reflection at the rear surface.

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It has been found that in optical-reflectivity
measurements on an article of translucent material, the
dimensions of the illuminated and measured areas of the
surface (respectively called the frame of illumination
and the frame of measurement) in relation to the
depth of penetration of the light into the translucent
material are of paramount significance in the sense that,
if the frame of illumination and the frame of measurement
are not large relative to the depth of penetration of the
light, the results of the measurement (the measured
flux of reflected light) are dependent on the frame size.

This dependence on the frame size is best seen when the frame of illumination and the frame of measurement are of approximately the same size, and has been found to be reversible when the frame size is selected to be of the order of the depth of penetration of the light. In this case it is found that with fixed frames of illumination and measurement the flux of reflected light observed is dependent on the depth of penetration of the light, and hence on scattering or the coefficient of scattering. This provides the possibility, in cases in which the only variable is the concentration of the particles in the translucent material that cause the scattering, to measure this concentration. The optical reflection meter could in this case be called a scattering monitor.

When, during measurement, conditions have been selected so that the depth of penetration is short

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relative to the dimensions of the frames, it turns out that the opacity of the translucent material has no effect on the reflected light observed. In that case the device can be called a reflection meter.

By using optic fibres in the optical reflection meter according to the invention, a flexible probe head arrangement is combined with the possibility of realizing - in a simple manner, by proper selection of fibre diameters - very small illumination and measurement frames in the order of a few tenths of a millimeter. The possibility provided by the present invention, therefore, leads to the realization of very small frame dimensions and hence miniaturization of the probe head, and, together with the flexible probe head connection, to wider applicability of the meter in that even places which are accessible and can be reached with difficulty only, can be approached and measured.

It can be deduced from the above observations with regard to frame size dependency in relation to depth of light penetration that the optical reflection meter is more suitable for use as a scattering monitor according as the frames of illumination and measurement are smaller. The reason is that when the apparatus according to the invention is used with different materials of various opacities, the adjustment of the probe head can longer satisfy the above condition that the size of the frames must not be much larger than the depth of penetration.

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Owing to the selected geometry for illumination of the surface to be measured and reception of the reflected light of 45° and 0°, respectively, it is possible, by providing a second optic illumination fibre in the probe head symmetrically relatively to the measuring fibre, to produce a measuring arrangement which, within certain limits, is independent of the flatness of the surface being measured, as will be described more fully hereinafter.

The invention will now be described in greater detail with reference to the accompanying drawings, in which

Fig. 1 is a diagrammatic illustration of an optical reflection meter according to the present invention;

Fig. 2 is a diagrammatic front-elevational view of the probe head, comprising two optic illumination fibres and a measuring fibre;

Fig. 3 shows the probe head of Fig. 2 in sideelevational view;

Fig. 4 shows the probe head of Fig. 2 in bottom view;

Fig. 5 is a graph showing the relationship between the flux of the reflected light and the adjustment of the angle between the axis of the probe head and the normal to the sample;

25 Fig. 6 is a graph showing the relationship between the distance between the probe head and the surface being measured and the relative portion of specular reflected light: and

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Fig. 7 is a graph showing the effect of the linear scattering coefficient on the signal, measured on different papers in layers of different thicknesses and with different backgrounds.

In the apparatus according to the invention (Fig. 1), light is conducted solely by means of quartz fibres; lenses and mirrors are not used. Shown at 1 and 2 are illuminating fibres serving for illumination of the preparation to be examined, and at 3 a measuring fibre.

Illumination fibres 1, 2 are fixed at their ends, together with an optic fibre 5 in an illuminating head 14. Illuminating head 14 is in juxtaposition to an illuminating element 12, which comprises an elongated flashlight 4 connected to a source of high voltage 13. Flashlight 4 illuminates the array of the ends of fibres 1, 2, 5, which have been ground to form a flat surface. These accordingly all receive the same flux; fine adjustment of this equality is possible by tilting the array of fibre ends in the plane containing the source of light and the array of fibre ends. The central fibre 5 is used for the reference beam, to which we will revert hereinafter. The distance between light source 4 and the array of fibre ends has been selected so that the width of the source just fills up the angle of acceptance of the fibres. Spectral selection is effected by means of a disc-shaped interference filter wedge 6, the axis of which is co-planar with the light

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source and the array of fibre ends. For all fibres the same wavelength is selected without the use of lenses or mirrors or other aids. The disc is placed in close proximity to the array of fibre ends, and the spectral width of the system is thus exclusively determined by the fibre diameter.

Illumination of the sample 15 and collection of the reflected light, without the specular-reflected light, are effected by means of a probe head 7, into which the fibre ends have been cast-in (Fig. 2-4). Illumination and observation through illumination fibres 1, 2 and measuring fibre 3, respectively, are effected at respective angles of 45° and 0° .

it is achieved that the adjustment of the angle between the axis of the probe head and the normal to the sample is not very critical. This is apparent from Fig. 5, which is a graph showing the relationship between the reflection received from a plurality of samples, plotted along the Y-axis, and expressed in the percentage of the light reflected by a BaSO₄ pill (international standard for 100% surface diffuse reflection), and the illumination angle A and the measuring angle B (0° corresponds to the normal), both plotted along the X-axis. The data points marked with a A in Fig. 5 relate to a preparation in the form of the BaSO₄ pill. Furthermore O relates to demineralized dental enamel and \(\sigma\) to healthy dental enamel, all of the

data points referred to relating to bilateral illumination of sample 15 through optical illumination fibres 1,2.

The data points marked with the corresponding closed signs, A, C, Prelate to analogous measurements, with the understanding that the sample was illuminated through one fibre only.

The illumination frame and measurement frame are as equal as can possibly be achieved with a flat probe head end. The distance between the surface of the probe head and the surface of the sample in combination with 10 the distances between the fibre ends play an important role in connection with the equality referred to: in the geometry used, light specular reflected once at the sample surface is not accepted by the measuring fibre 3. Light specular reflected three times (sample - probe head 15 surface - sample) is accepted. In the case of non-metallic reflecting surfaces, however, this contribution is slight: with an index of refraction $n_{sample} = 1.57$, the thrice reflected flux is less than 0.5% of the flux returned 20 by a sample by way of diffuse white reflection. Control experiments have shown, however, that with the fibre diameter used a selected probe head-to-sample distance of 0.3 ± 0.2 mm is the correct one, in which connection reference is made to Fig.6, the ratio of the intensities 25 of the reflected light, measured relative to a BaSO, pill, to that of an aluminium mirror is plotted along the Y-axis, and the distance in millimeters of the probe head from the surface heing measured is blotted along the Y-avis

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Technically this distance is determined by two small pins 8 and 9 (Fig. 3-4) on the probe head. By virtue of this arrangement the head can also be used on curved surfaces. Also, the distance is not dependent on the angle at which the head is to the surface. If desired a probe head with a spacer ring can be used for flat samples.

Light detection is accomplished through photodiodes in an integrated circuit, shown at 15 for the reference beam and at 16 for the reflected light from the sample, with an operational amplifier shown at 17 and 18, respectively.

The central fibre 5 of the array of fibres directed to the source of light 4 shines on a BaSO₄ pill 10 (Fig. 1) at an angle of 45°. In a similar geometry to the probe head, a reference observation fibre 11 receives the light reflected along the normal (0°), which is passed to the separate photodioade 15. The use of other non-white standards is of course possible. There is thus formed a twin-bundle spectrophotometer.

The gas discharge or flash light is driven pulse-wise, as is known per se. The pulses, from the photodiodes, are separated from other signals, as a result of which the instrument does not perceive ambient light. A divider circuit 19 subsequently divides the probe head signal y by the reference signal x. The amplification of the reference signal in amplifier 17 and the amplification of the probe head signal in amplifier 18 can be adjusted externally. By

placing probe head on a standard preparation, full-scale deflection can be adjusted on meter 20.

Using the meter as shown diagrammatically in Fig. 1, measurements have been made to determine the effect of the linear scattering coefficient on the signal, using different kinds of paper in layers of different thickness, and with different background. The decadic scattering coefficient of the three papers was measured separately by a method already used previously, employing a 10 spectrophoto meter with an integrating ball (Calcif. Tiss. Ris. 17 (1975) 129-137). In this connection it was assumed that paper consists of scattering particles in air. Fig. 7 shows the results of the measurement. The reflection in % of the reflection of a BaSO₄-pill is plotted along the vertical axis, and the thickness 15 of the measured paper layer along the horizontal axis. The open symbols \triangle , \bigcirc , \bigcirc relate to measurements on paper without using a background, and the closed symbols A, O, a on the use of a background in the form of an 20 aluminium mirror. Furthermore, the symbol A corresponds with typewriting paper having a linear scattering coefficient $s_c = 66.4 \text{ mm}^{-1}$; the symbol \square with balance pan paper whose $s_c = 21.1 \text{ mm}^{-1}$ and the symbol 0 with drawing paper whose $s_c = 9.18 \text{ mm}^{-1}$. Figure 7 25 shows that the reflection becomes independent of the background at layer thicknesses of approximately 0.2 mm. This distance is almost independent of the scattering coefficient of the material. In this instance the meter works as a scattering monitor; the signal is determined

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By using more optic illumination fibres in the probe head, the frame of illumination can be increased so that the meter reading becomes independent of the depth of light penetration, as a result of which a $45^{\circ}/0^{\circ}$ geometry reflectometer is formed.

If desired, very long fibres (e.g. 25~m) can be used between the apparatus and the probe head without any objection.

When the set angle between the measuring fibre and the illumination fibre is adapted to the index of refraction of the medium between the probe head and the sample, it is possible to make measurements in liquid. For water (n = 1.33), for example, the angle should be 40.3° , and in air 29° .

It is possible for the reflection spectrum obtained with the meter according to the invention to be stored by means of a built-in microprocessor, and to convert it to colour points under standard illumination. As the meter, which functions as a monitor, produces a reflection spectrum, it is not necessary to use a standard light source. The data of the standard light source just occur in the calculation, and must therefore be available in the memory of the processor.

It will be clear, for that matter, that the apparatus described above and shown in the accompanying drawings can be modified without departing from the scope of the present invention.

CLAIMS

1. An optical reflection meter suitable for reflection measurement on a shaped or shapeless translucent material, comprising a source of light, a probe head, a light detection means, at least one optic illumination fibre between the light source and the probe head for illumination of the surface to be measured, and at least one optic measuring fibre between the probe head and the light detection means for receiving the reflected light and conducting the same to the light detection means, characterized in that the probe head comprises one optic measuring fibre; the geometry maintained relative to the surface to be measured for illumination of said surface and for reception of the reflected light being 45° and 0°, respectively; the surface area to be measured, or frame of measurement, determined by the optic measuring fibre, being of the order of the depth of light penetration into the material to be measured, or less, and the portion of the surface to be measured illuminated by the optic illumination fibre, or frame of illumination, being of at least substantially the same size as the frame of measurement or larger.

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2. Apparatus as claimed in claim 1, characterized in that the probe head comprises a second optic illumination fibre, one end of which is positioned in said probe head on an imaginary line co-extensive with the line connecting the ends of said first optic illumination fibre and

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said measuring fibre, and equidistantly spaced from the end of the measuring fibre.

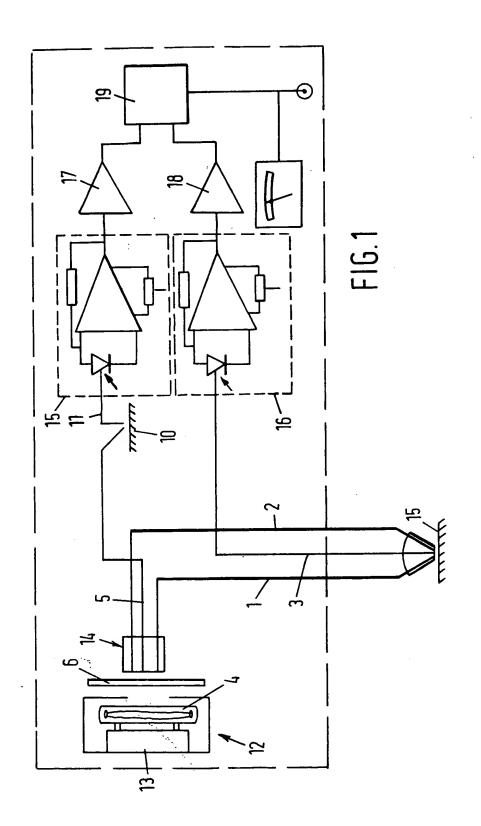
- 3. Apparatus as claimed in either of claims 1 and 2, in which the probe head comprises a spacer member for keeping the ends of the optic fibres located in said head in spaced relationship to the surface being measured, characterized in that, during measurements, said spacer member can keep the optic fibre ends spaced such a distance from the surface being measured that light specular reflected once at said surface cannot be accepted by the measuring fibre.
- 4. Apparatus as claimed in claim 3, characterized in that said spacer member comprises two outwardly directed pins located in an imaginary line containing the end of the measuring fibre and perpendicular to the line connecting the ends of the optical fibres, and said pins being arranged symmetrically relative to the end of the measuring fibre.
- 5. Apparatus as claimed in any of claims 1-4,

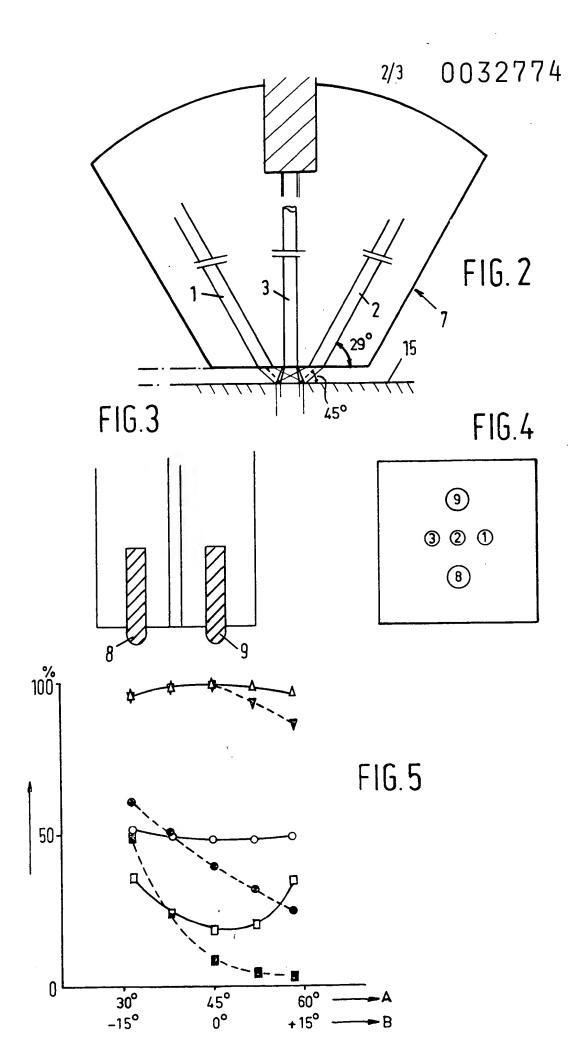
 comprising a pulsating light source, characterized in that said light source is of elongated shape and extends parallel to the line connecting the ends of the illumination fibres to be illuminated by said light source, said ends being fixed in an illumination head.
- 25 6. Apparatus as claimed in claim 5, characterized in that the distance between the elongated light source and said illumination head has been so selected that the width of the light source just fills up the angle

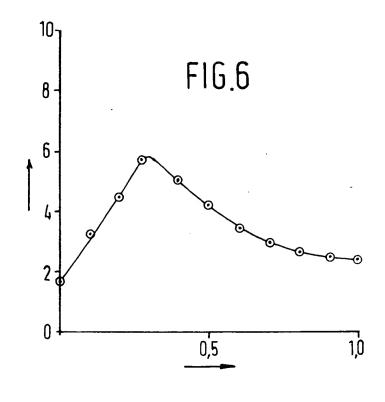
of acceptance of the fibres.

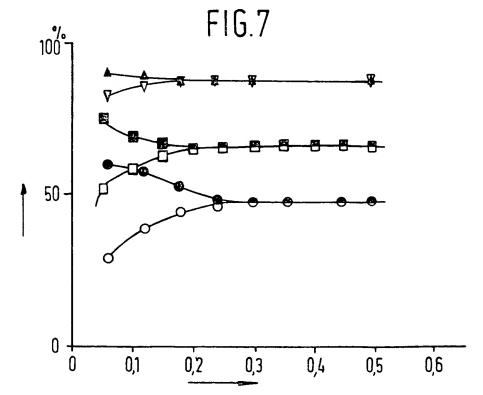
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- 7. Apparatus as claimed in any of claims 5-6, characterized by the provision of an interference filter wedge between the light source and the array of fibre ends for variable spectral selection without lenses or mirrors.
- 8. Apparatus as claimed in any of claims 4-7, characterized in that the end of a reference illumination fibre, the other end of which is directed to the surface of a reference material, is fixed in said illumination head between the ends of the illumination fibres, and is combined by the 45°-0° geometry with a reference measuring fibre with which the light reflected by said reference material according to the normal can be received.
 - 9. Apparatus as claimed in any of claims 5-8, characterized in that the array of fibre ends is tiltable through the illumination head in the plane containing the array of fibre ends and the elongated light source.









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